

N-Channel 40-V (D-S) MOSFET

Description

The device is using trench DMOS technology. This advanced technology has been especially tailored to minimize $R_{DS(ON)}$, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

The device meets the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

Features

- R_{DS(ON)} = 3.2mΩ @ V_{GS} = 10V
- Low Gate Charge
- Excellent dv/dt Capability
- 100% EAS Guaranteed
- Green Device Available

Typical Applications

- Power Management in Desktop Computer
- DC/DC converters
- Synchronous rectifier applications

Package type : PDFN 5X6

Packing & Order Information

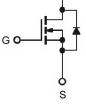
3,000/Reel



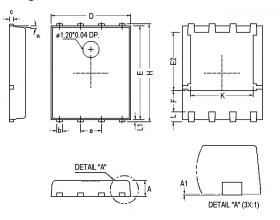




Graphic Symbol

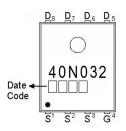


Package Dimension



REF.	Millimeter			REF.	Millimeter			
	Min.	Nom.	Max.		Min.	Nom.	Max.	
Α	0.85	1.00	1.15	E	5.70	-	5.90	
A1	0.00	-	0.10	e	-	1.27	-	
b	0.30	-	0.51	H	5.90	-	6.20	
С	0.20	-	0.30	L	-	0.60	-	
D	4.80	-	5.00	L1	0.06	-	0.20	
F	1.10 Ref.			α	0 °	-	12°	
E2	3	3.50 Ref.		K	3.70	3.90	4.10	

Marking





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MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings					
Symbol	Parameter	Value	Units		
VDS	Drain-Source Voltage	40	V		
V _{GS}	Gate-Source Voltage	±20	V		
1	Continuous Drain Current ¹ (T _c =25°C)	90	А		
ID	Continuous Drain Current ¹ (T _c =100°C)	72	А		
I _{DM}	Pulsed Drain Current ^{1,2}	240	А		
I _{AS}	Single Pulse Avalanche Current, L =0.1mH ³	54	А		
E _{AS}	Single Pulse Avalanche Energy, L =0.1mH ³	145	mJ		
PD	Power Dissipation ⁴ (T _c =25°C)	50	W		
TJ/Tstg	Operating Junction and Storage Temperature	-55 to 150	°C		

Thermal Resistance Ratings						
Symbol	Parameter	Maximum	Units			
Reja	Maximum Junction-to-Ambient ¹	55	°C/W			
Rejc	Maximum Junction-to-Case ¹	2.5	°C/W			

Electrical Characteristics (T」=25°C unless otherwise specified)						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
VGS (th)	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1.2	-	2.2	V
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250µA	40	-	-	V
I _{GSS}	Gate-Source Leakage Current	V _{DS} =0V, V _{GS} =±20V	-	-	±100	nA
IDSS	Drain-Source Leakage Current	V _{DS} =40V, V _{GS} =0V, T _J =25°C	_	-	1	μA
		V_{DS} =40V, V_{GS} =0V, T_{J} =55°C			5	
$R_{DS \ (on)}$	Static Drain-Source On-Resistance ²	V _{GS} =10V, I _D =20A	-	2.5	3.2	mΩ
		V _{GS} =4.5V, I _D =15A	-	3.8	5.3	11152
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =25V, L =0.1mH, I _{AS} =25A	31	-	-	mJ
Vsd	Diode Forward Voltage ²	Is =1A, V _{GS} =0V, T _J =25°C	-	-	1.0	V
ls	Continuous Source Current ^{1,6}	$V_G = V_D = 0V$, Force Current	-	-	30	
Ism	Pulsed Source Current ^{2,6}		-	-	60	A



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Dynamic						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Qg	Total Gate Charge ²	V _{DS} =20V		22.7		
Qgs	Gate-Source Charge	I _D =20A		7.5		nC
Q _{gd}	Gate-Drain Charge	V _{GS} =10V		5.5		
td(on)	Turn-On Delay Time ²	V _{DS} =20V		10		
tr	Rise Time	I _D =20A		5		
td(off)	Turn-Off Delay Time	V _{GS} =10V		33		ns
tf	Fall Time	$R_{G}=3\Omega$		6.5		
CISS	Input Capacitance	V _{DS} = 20V		2648		
Coss	Output Capacitance	V _{GS} =0V		899		pF
C _{RSS}	Reverse Transfer Capacitance	f=1.0MHz		71		1
Rg	Gate Resistance	V _{DS} =0V, V _{GS} =0V, f =1.0MHz		1.5		Ω

Notes

1. The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.

2. The data tested by pulsed, pulse width \leq 300us, duty cycle \leq 2%.

3. The EAS data shows maximum rating. The test condition is V_{DD} =25V, V_{GS} =10V, L=0.1mH, I_{AS}=54A.

4. The power dissipation is limited by 150 $^\circ\!\mathrm{C}$ junction temperature.

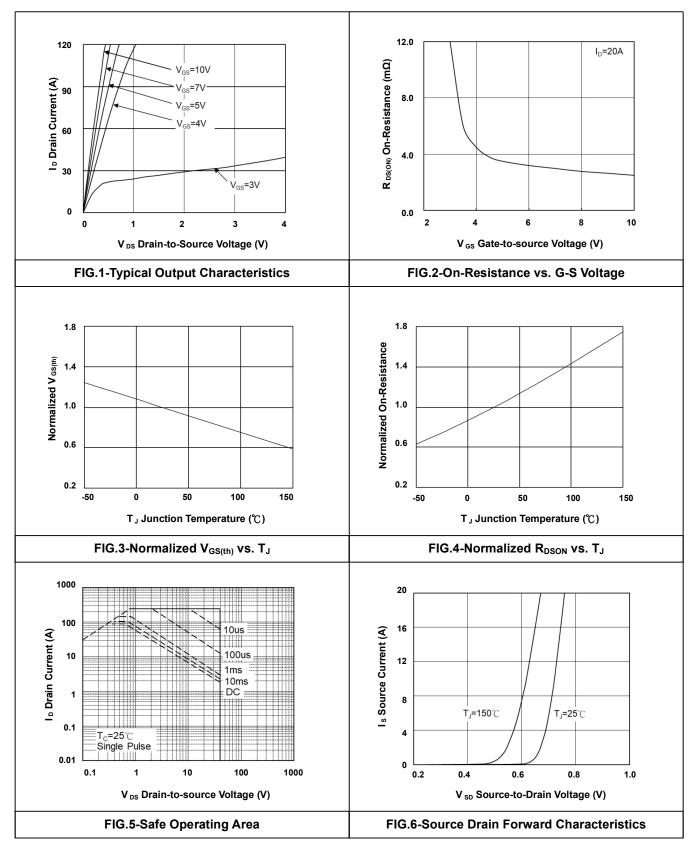
5. The Min. value is 100% EAS tested guarantee.

6. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



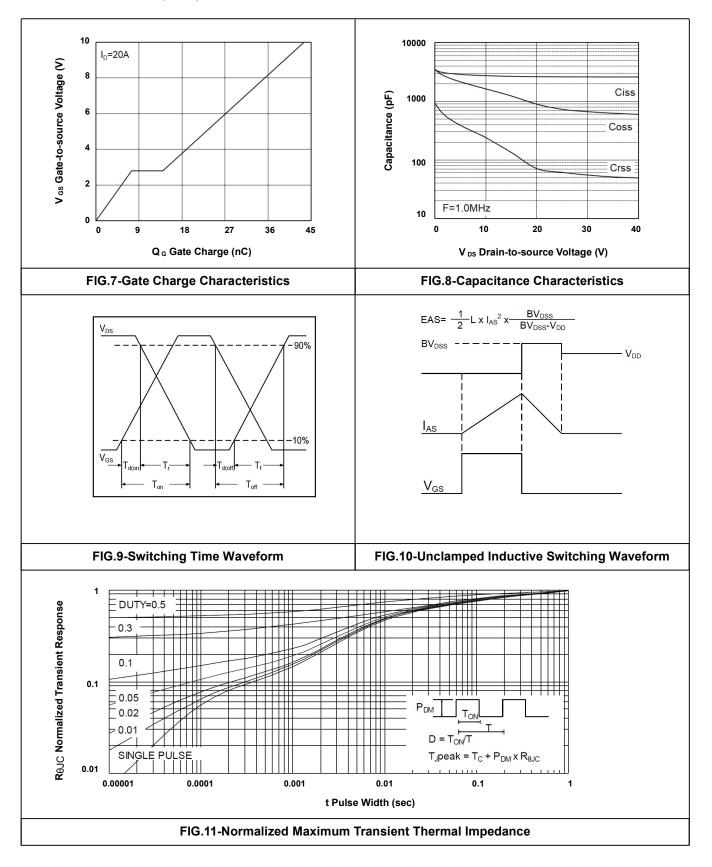
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• Typical Electrical Characteristics





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